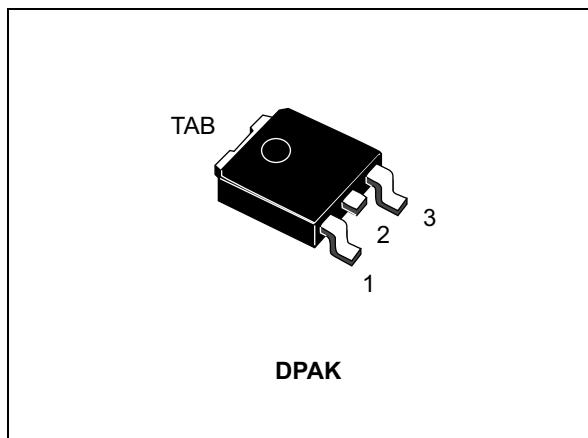
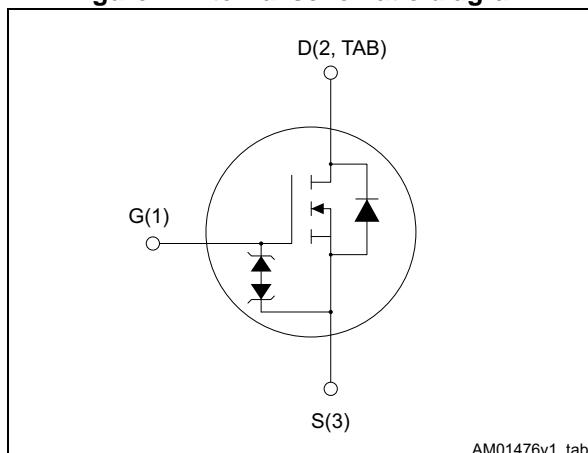


## Automotive-grade N-channel 1000 V, 5.6 Ω typ., 2.2 A SuperMESH™ Power MOSFET Zener-protected in a DPAK

Datasheet - production data



**Figure 1. Internal schematic diagram**



## Features

Order code	V <sub>DSS</sub>	R <sub>DS(on)max</sub>	I <sub>D</sub>
STD4NK100Z	1000 V	6.8 Ω	2.2 A

- Designed for automotive applications and AEC-Q101 qualified
- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitance
- Zener-protected

## Applications

- Switching application

## Description

This device is an N-channel Zener-protected Power MOSFET developed using STMicroelectronics' SuperMESH™ technology, achieved through optimization of ST's well established strip-based PowerMESH™ layout. In addition to a significant reduction in on-resistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

**Table 1. Device summary**

Order code	Marking	Package	Packaging
STD4NK100Z	4NK100Z	DPAK	Tape and reel

**Note:** HTRB test has been performed at 80% of V<sub>(BR)DSS</sub> according to AEC-Q101 rev. C. All the other tests have been done according to the new rev. D.

## Contents

<b>1</b>	<b>Electrical ratings</b>	<b>3</b>
<b>2</b>	<b>Electrical characteristics</b>	<b>4</b>
2.1	Electrical characteristics (curves)	6
<b>3</b>	<b>Test circuits</b>	<b>8</b>
<b>4</b>	<b>Package information</b>	<b>9</b>
<b>5</b>	<b>Packing information</b>	<b>13</b>
<b>6</b>	<b>Revision history</b>	<b>15</b>

# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	1000	V
$V_{GS}$	Gate-source voltage	$\pm 30$	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	2.2	A
$I_D$	Drain current (continuous) at $T_C=100^\circ\text{C}$	1	A
$I_{DM}^{(1)}$	Drain current (pulsed)	8.8	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	90	W
$V_{ESD(G-S)}$	Gate source ESD (HBM-C=100pF, $R=1.5\text{ k}\Omega$ )	3000	V
$d_v/d_t^{(2)}$	Peak diode recovery voltage slope	4.5	V/ns
$T_J$ $T_{stg}$	Operating junction temperature Storage temperature	-55 to 150	$^\circ\text{C}$

1. Pulse width limited by safe operating area
2.  $I_{SD} \leq 2.2\text{ A}$ ,  $di/dt \leq 200\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_j \leq T_{JMAX}$ .

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	1.39	$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb max	50	$^\circ\text{C/W}$

1. When mounted on 1inch<sup>2</sup> FR-4 board, 2 oz Cu

**Table 4. Avalanche characteristics**

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_{JMAX}$ )	2.2	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j=25^\circ\text{C}$ , $I_D=I_{AR}$ , $V_{DD}=50\text{ V}$ )	110	mJ

## 2 Electrical characteristics

( $T_{CASE}=25\text{ }^{\circ}\text{C}$  unless otherwise specified)

**Table 5. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 1\text{ mA}, V_{GS} = 0$	1000			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 1000\text{ V}, V_{GS} = 1000\text{ V}, T_c = 125\text{ }^{\circ}\text{C}$			1 50	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{GS} = 0$ )	$V_{GS} = \pm 20\text{ V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 50\text{ }\mu\text{A}$	3	3.75	4.5	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}, I_D = 1.1\text{ A}$		5.6	6.8	$\Omega$

**Table 6. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 25\text{ V}, f = 1\text{ MHz}, V_{GS} = 0$	-	601	-	pF
$C_{oss}$	Output capacitance		-	53	-	pF
$C_{rss}$	Reverse transfer capacitance		-	12	-	pF
$C_{oss\ eq}^{(1)}$	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0\text{ V to }800\text{ V}$	-	15	-	pF
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 500\text{ V}, I_D = 1.25\text{ A}, R_G = 4.7\text{ }\Omega, V_{GS} = 10\text{ V}$ (see <a href="#">Figure 16</a> )	-	15	-	ns
$t_r$	Rise time		-	7.5	-	ns
$t_{d(off)}$	Off-voltage rise time		-	32	-	ns
$t_f$	Fall time		-	39	-	ns
$Q_g$	Total gate charge	$V_{DD} = 800\text{ V}, I_D = 2.5\text{ A}$ $V_{GS} = 10\text{ V}$ (see <a href="#">Figure 15</a> )	-	18	-	nC
$Q_{gs}$	Gate-source charge		-	3.6	-	nC
$Q_{gd}$	Gate-drain charge		-	9.2	-	nC

1.  $C_{oss\ eq}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		2.2	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		8.8	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD}= 2.2 \text{ A}, V_{GS}=0$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD}= 2.5 \text{ A},$ $di/dt = 100 \text{ A}/\mu\text{s},$ $V_{DD}=100 \text{ V}$ (see <a href="#">Figure 14</a> )	-	584		ns
$Q_{rr}$	Reverse recovery charge		-	2.3		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	8		A
$t_{rr}$	Reverse recovery time	$I_{SD}= 2.5 \text{ A},$ $di/dt = 100 \text{ A}/\mu\text{s},$ $V_{DD}=100 \text{ V}, T_j=150 \text{ }^\circ\text{C}$ (see <a href="#">Figure 14</a> )	-	628		ns
$Q_{rr}$	Reverse recovery charge		-	2.5		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	8.1		A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300  $\mu\text{s}$ , duty cycle 1.5%

**Table 8. Gate-source Zener diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{gs}=\pm 1 \text{ mA}, I_D=0$	30	-		V

The built-in back-to-back Zener diodes have specifically been designed to enhance the device's ESD capability. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

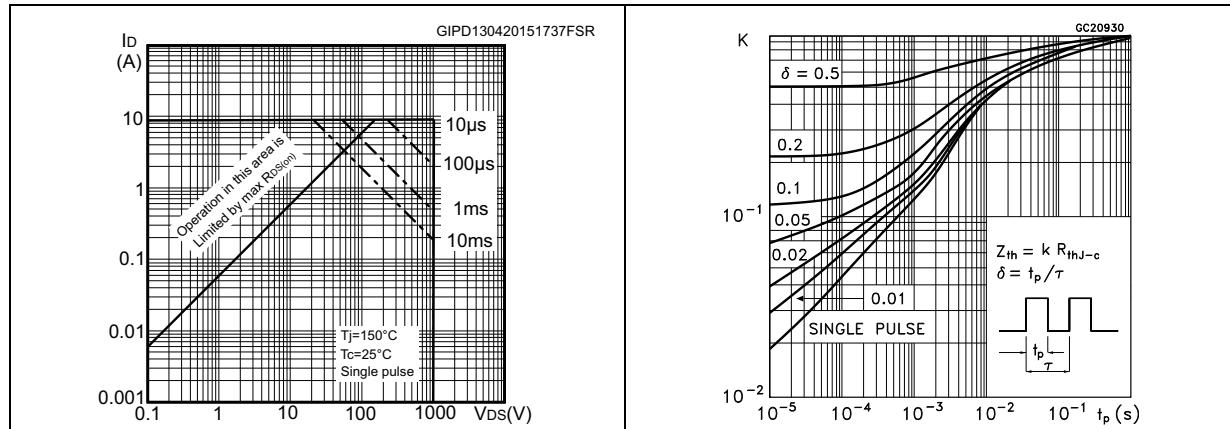


Figure 3. Thermal impedance

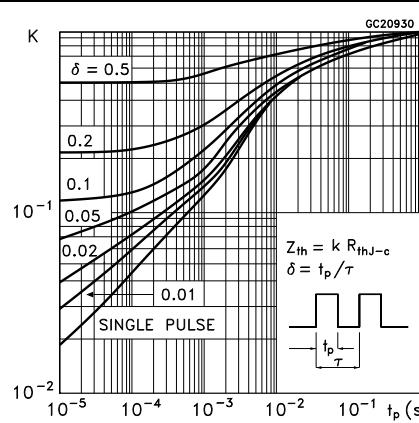


Figure 4. Output characteristics

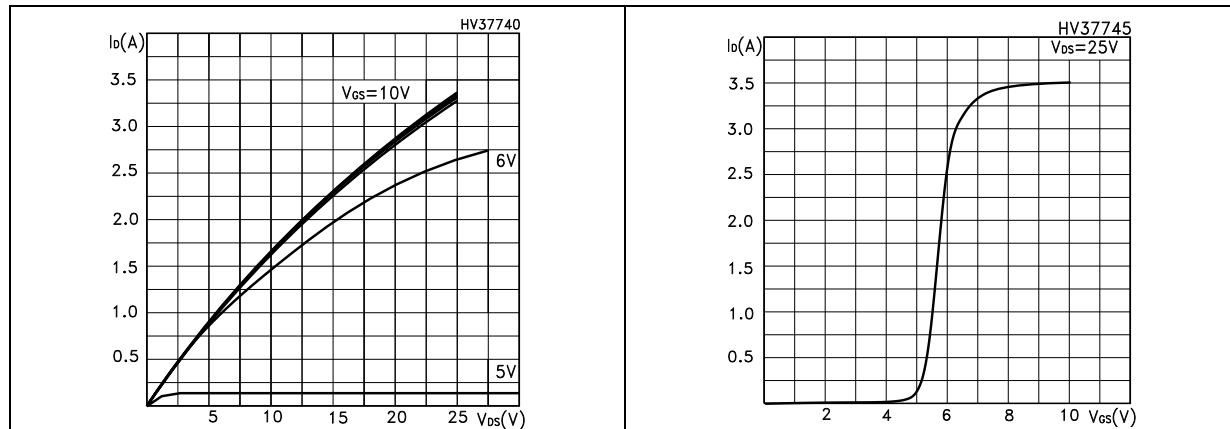


Figure 5. Transfer characteristics

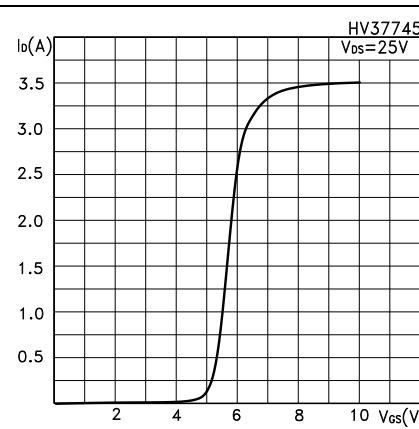
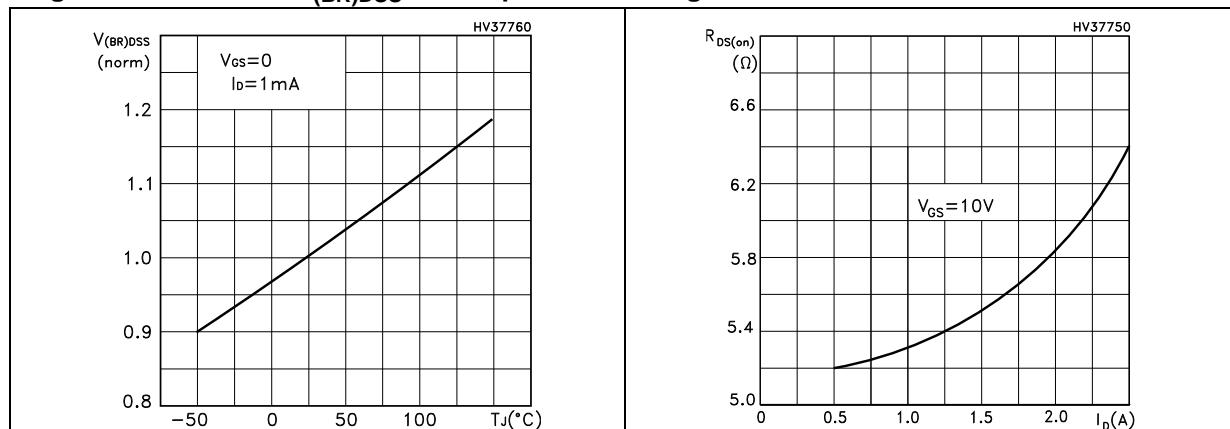
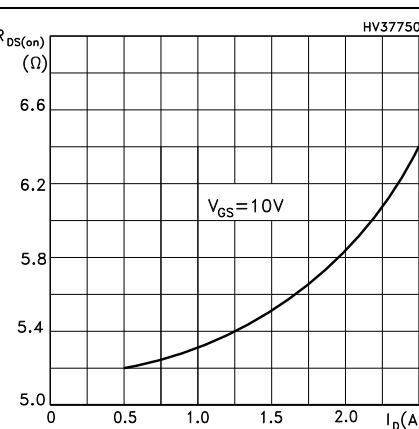
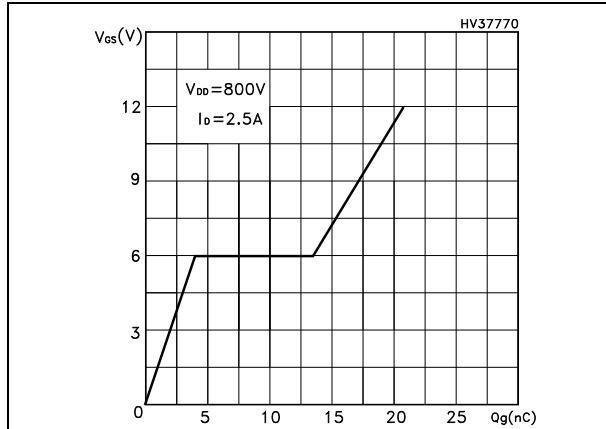
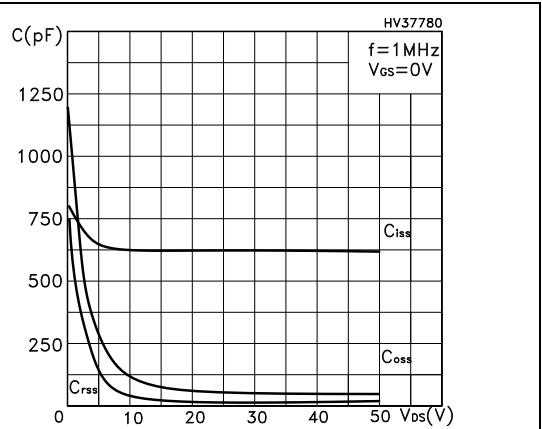
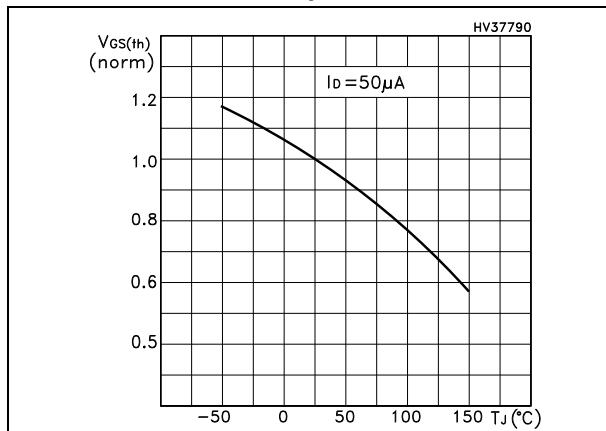
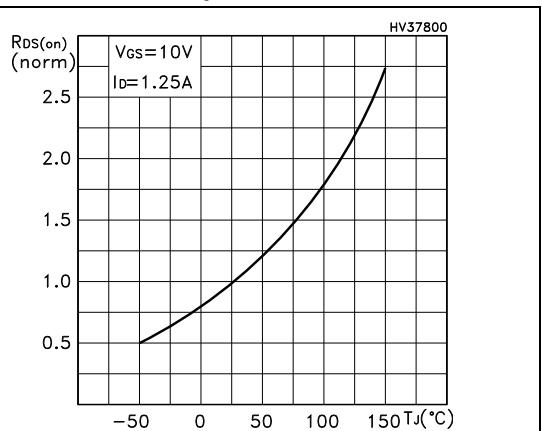
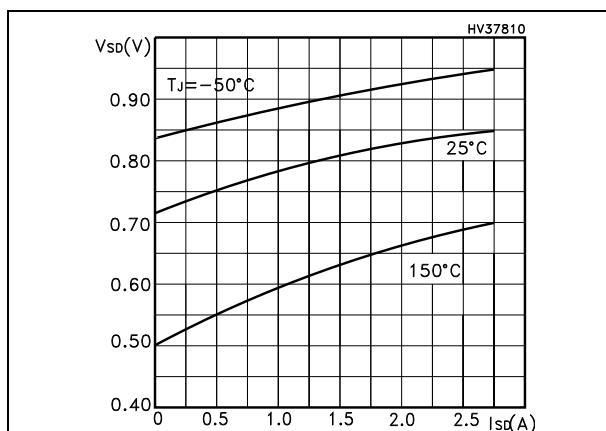
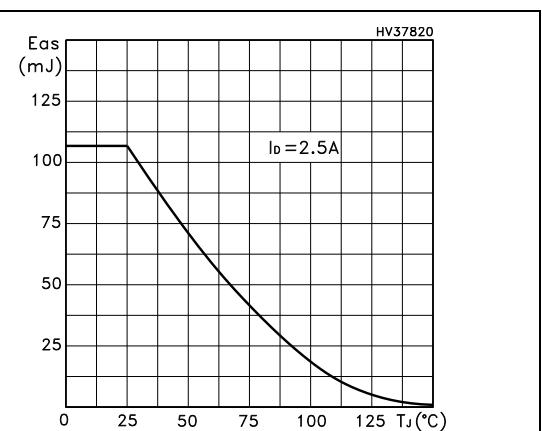
Figure 6. Normalized  $V_{(BR)DSS}$  vs. temperature

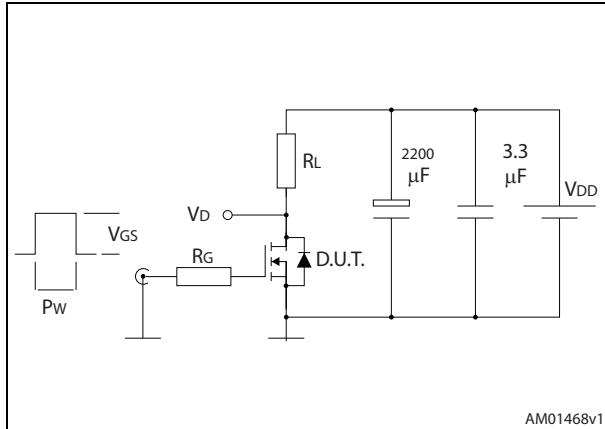
Figure 7. Static drain-source on-resistance



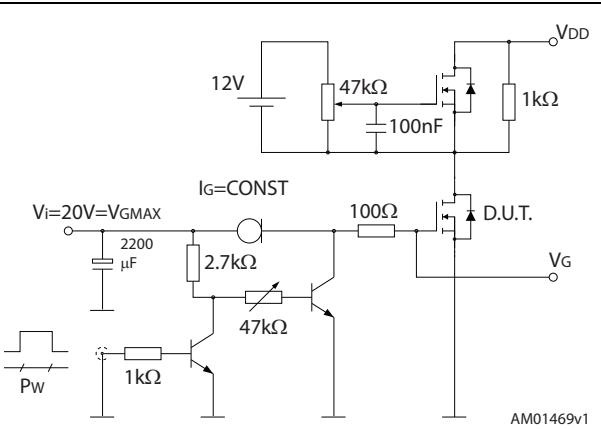
**Figure 8. Gate charge vs. gate-source voltage****Figure 9. Capacitance variations****Figure 10. Normalized gate threshold voltage vs. temperature****Figure 11. Normalized on-resistance vs. temperature****Figure 12. Source-drain diode forward characteristics****Figure 13. Maximum avalanche energy vs  $T_j$** 

### 3 Test circuits

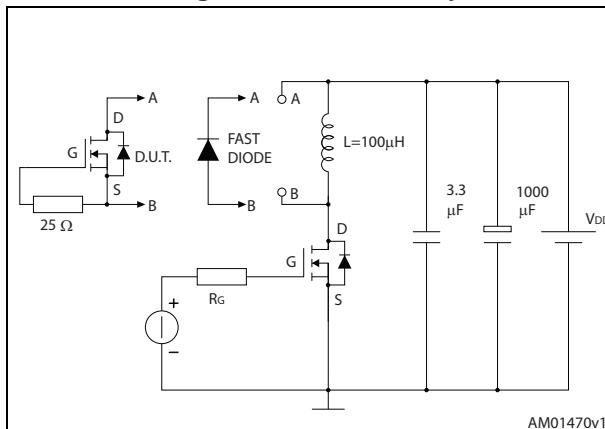
**Figure 14. Switching times test circuit for resistive load**



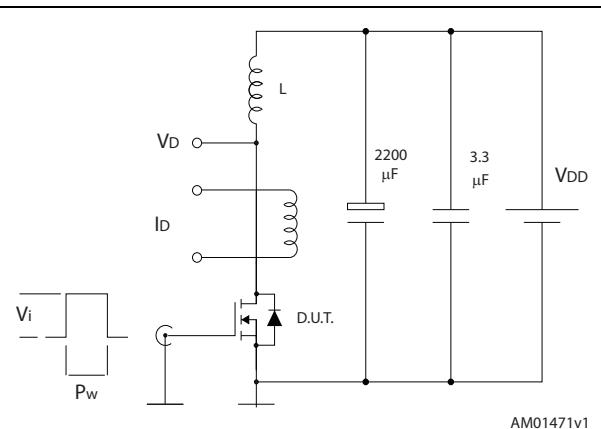
**Figure 15. Gate charge test circuit**



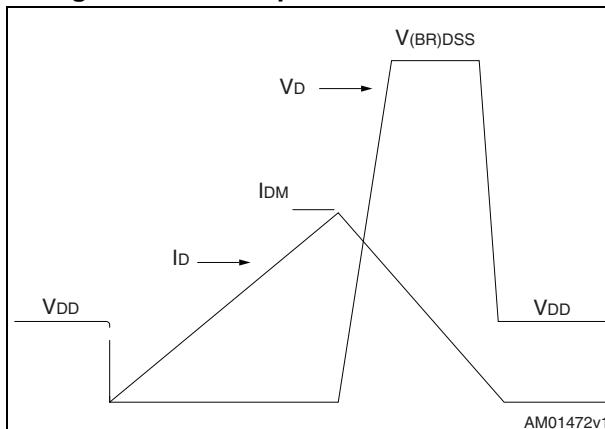
**Figure 16. Test circuit for inductive load switching and diode recovery times**



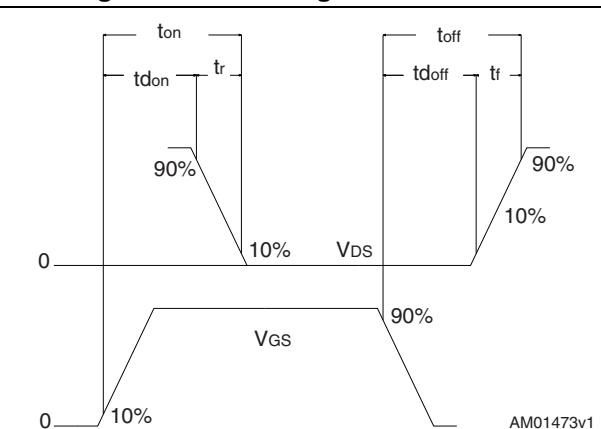
**Figure 17. Unclamped inductive load test circuit**



**Figure 18. Unclamped inductive waveform**



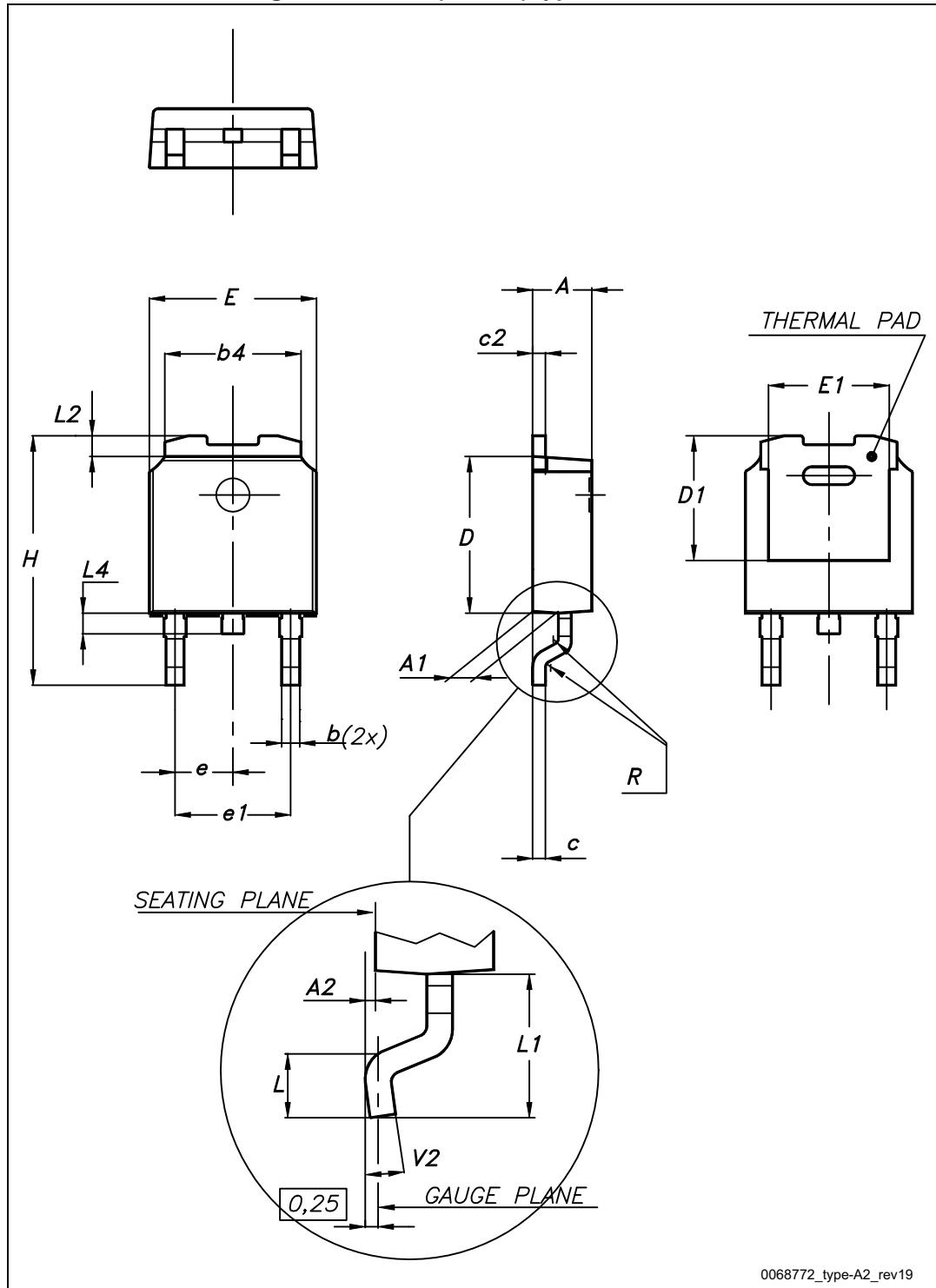
**Figure 19. Switching time waveform**



## 4 Package information

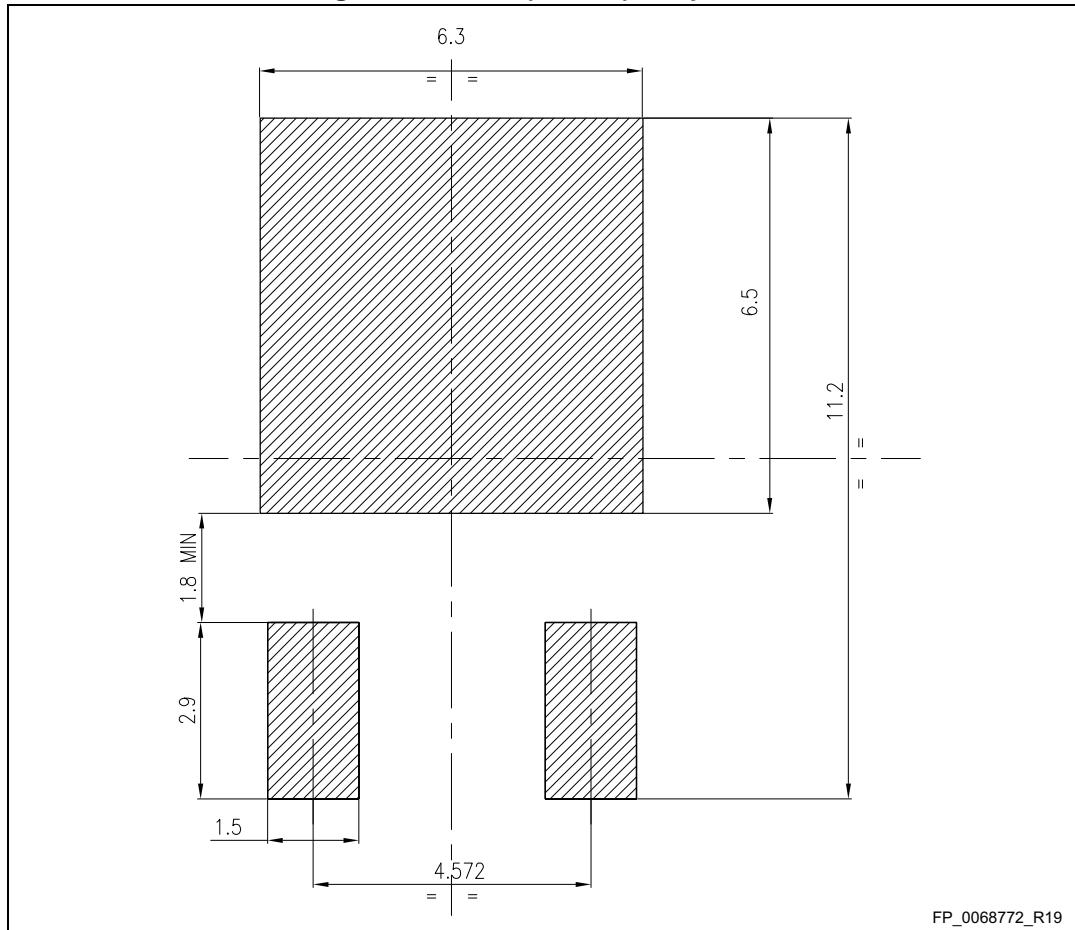
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK is an ST trademark.

Figure 20. DPAK (TO-252) type A2 outline



**Table 9. DPAK (TO-252) type A2 mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
E	6.40		6.60
E1	5.10	5.20	5.30
e	2.16	2.28	2.40
e1	4.40		4.60
H	9.35		10.10
L	1.00		1.50
L1	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°

**Figure 21. DPAK (TO-252) footprint (a)**

a. All dimensions are in millimeters

## 5 Packing information

**Table 10. DPAK (TO-252) tape and reel mechanical data**

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	6.8	7	A		330
B0	10.4	10.6	B	1.5	
B1		12.1	C	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	T		22.4
K0	2.55	2.75			
P0	3.9	4.1		Base qty.	2500
P1	7.9	8.1		Bulk qty.	2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			

Figure 22. Tape for DPAK (TO-252)

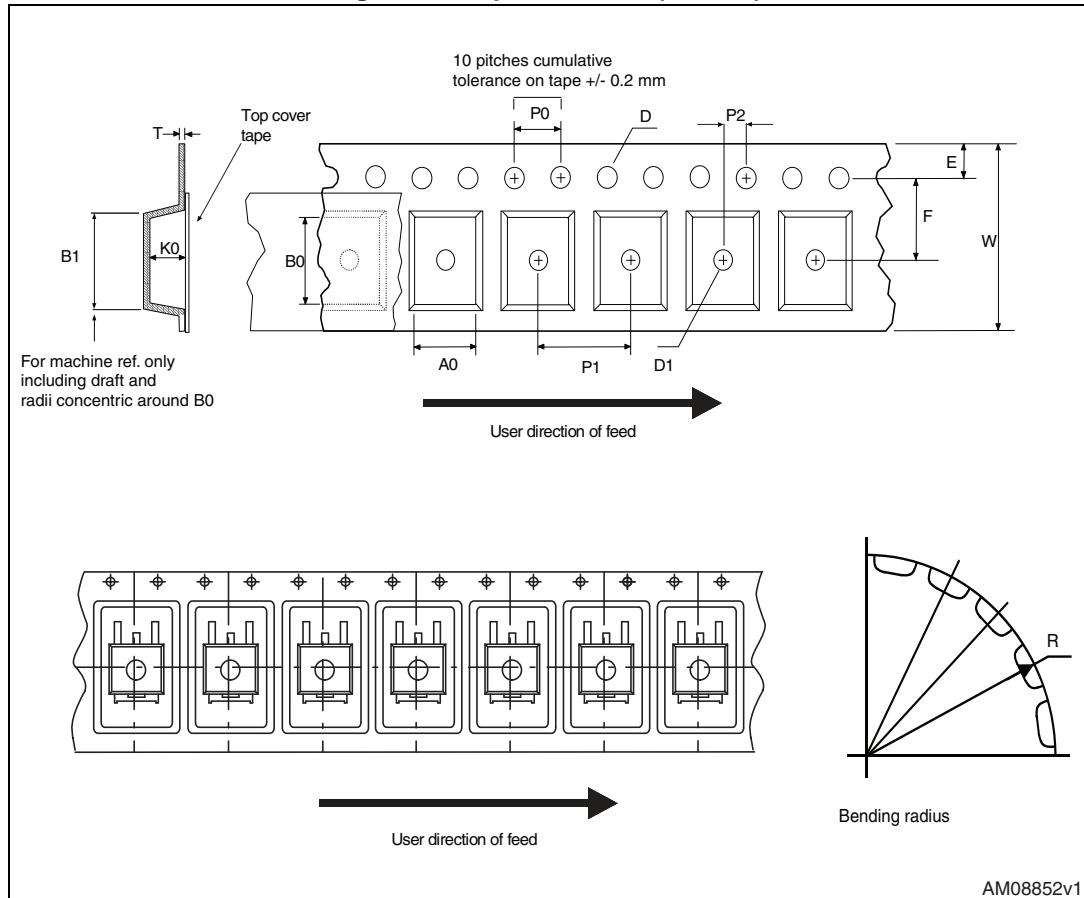
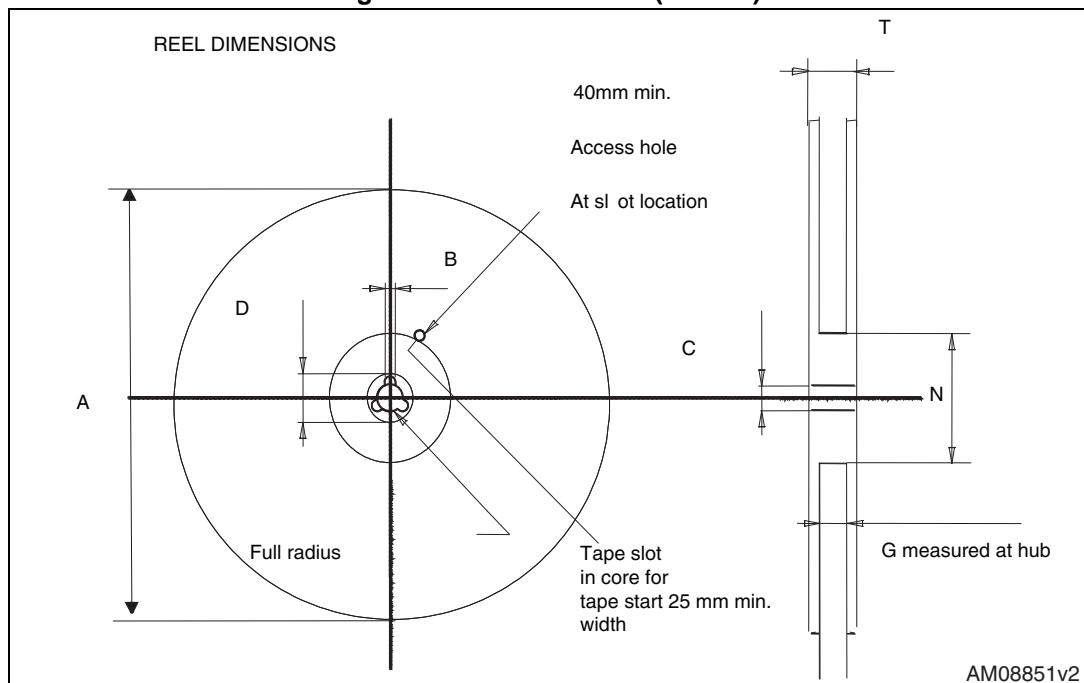


Figure 23. Reel for DPAK (TO-252)



## 6 Revision history

Table 11. Document revision history

Date	Revision	Changes
01-Oct-2013	1	First release.
13-Apr-2015	2	Document status promoted from preliminary to production data. Updated title and features in cover page. Updated <a href="#">Section 2.1: Electrical characteristics (curves)</a> and <a href="#">Section 4: Package information</a> . Minor text changes.

**IMPORTANT NOTICE – PLEASE READ CAREFULLY**

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics – All rights reserved